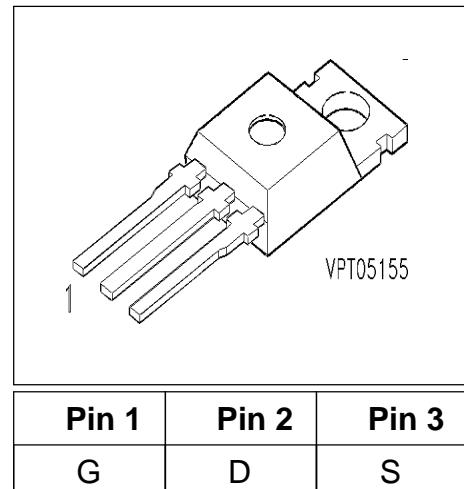


**SIPMOS® Power Transistor**

- N channel
- Enhancement mode



Type	$V_{DS}$	$I_D$	$R_{DS(on)}$	Package	Ordering Code
BUZ 50 B	1000 V	2 A	8 Ω	TO-220 AB	C67078-A1307-A4

**Maximum Ratings**

Parameter	Symbol	Values	Unit
Drain source voltage	$V_{DS}$	1000	V
Drain-gate voltage	$V_{DGR}$		
$R_{GS} = 20 \text{ k}\Omega$		1000	
Continuous drain current	$I_D$		A
$T_C = 25^\circ\text{C}$		2	
Pulsed drain current	$I_{Dpuls}$		
$T_C = 25^\circ\text{C}$		8	
Gate source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation	$P_{tot}$		W
$T_C = 25^\circ\text{C}$		78	
Operating temperature	$T_j$	-55 ... + 150	°C
Storage temperature	$T_{stg}$	-55 ... + 150	
Thermal resistance, chip case	$R_{thJC}$	$\leq 1.6$	K/W
Thermal resistance, chip to ambient	$R_{thJA}$	75	
DIN humidity category, DIN 40 040		C	
IEC climatic category, DIN IEC 68-1		55 / 150 / 56	

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**Static Characteristics**

Drain- source breakdown voltage $V_{GS} = 0 \text{ V}, I_D = 0.25 \text{ mA}, T_j = 25^\circ\text{C}$	$V_{(BR)DSS}$	1000	-	-	V
Gate threshold voltage $V_{GS}=V_{DS}, I_D = 1 \text{ mA}$	$V_{GS(\text{th})}$	2.1	3	4	
Zero gate voltage drain current $V_{DS} = 1000 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25^\circ\text{C}$ $V_{DS} = 1000 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 125^\circ\text{C}$	$I_{DSS}$	-	20	250	$\mu\text{A}$
		-	100	1000	
Gate-source leakage current $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	$I_{GSS}$	-	10	100	nA
Drain-Source on-resistance $V_{GS} = 10 \text{ V}, I_D = 1.5 \text{ A}$	$R_{DS(\text{on})}$	-	6.5	8	$\Omega$

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

### Dynamic Characteristics

Transconductance $V_{DS} \geq 2 * I_D * R_{DS(on)max}$ , $I_D = 1.5 \text{ A}$	$g_{fs}$	0.7	1.5	-	S
Input capacitance $V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{iss}$	-	1600	2100	pF
Output capacitance $V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{oss}$	-	70	120	
Reverse transfer capacitance $V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1 \text{ MHz}$	$C_{rss}$	-	30	55	
Turn-on delay time $V_{DD} = 30 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 2 \text{ A}$ $R_{GS} = 50 \Omega$	$t_{d(on)}$	-	30	45	ns
Rise time $V_{DD} = 30 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 2 \text{ A}$ $R_{GS} = 50 \Omega$	$t_r$	-	40	60	
Turn-off delay time $V_{DD} = 30 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 2 \text{ A}$ $R_{GS} = 50 \Omega$	$t_{d(off)}$	-	110	140	
Fall time $V_{DD} = 30 \text{ V}$ , $V_{GS} = 10 \text{ V}$ , $I_D = 2 \text{ A}$ $R_{GS} = 50 \Omega$	$t_f$	-	60	80	

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

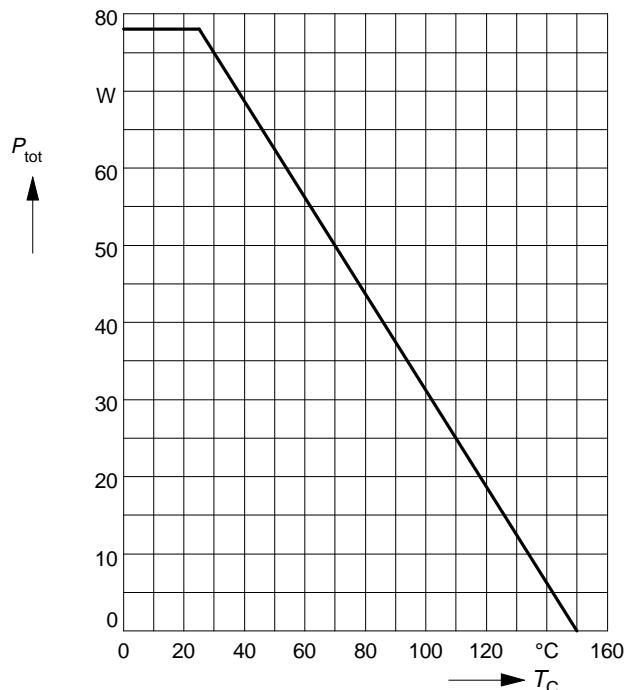
Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**Reverse Diode**

Inverse diode continuous forward current $T_C = 25^\circ\text{C}$	$I_S$	-	-	2	A
Inverse diode direct current,pulsed $T_C = 25^\circ\text{C}$	$I_{SM}$	-	-	8	
Inverse diode forward voltage $V_{GS} = 0 \text{ V}, I_F = 6 \text{ A}$	$V_{SD}$	-	1.05	1.3	V
Reverse recovery time $V_R = 100 \text{ V}, I_F=I_S, di_F/dt = 100 \text{ A}/\mu\text{s}$	$t_{rr}$	-	2	-	$\mu\text{s}$
Reverse recovery charge $V_R = 100 \text{ V}, I_F=I_S, di_F/dt = 100 \text{ A}/\mu\text{s}$	$Q_{rr}$	-	15	-	$\mu\text{C}$

### Power dissipation

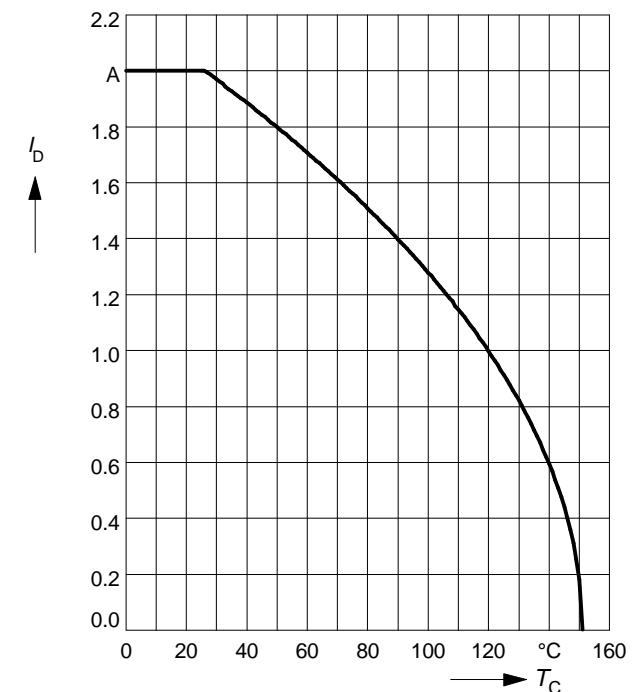
$$P_{\text{tot}} = f(T_C)$$



### Drain current

$$I_D = f(T_C)$$

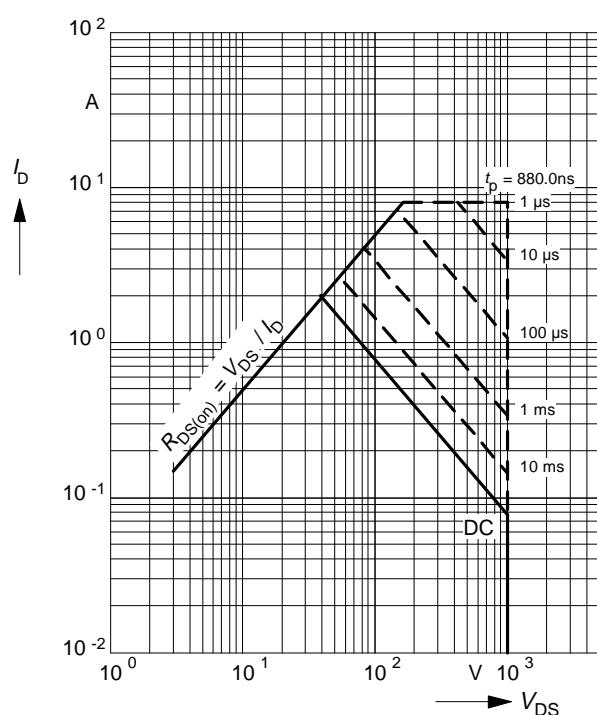
parameter:  $V_{GS} \geq 10$  V



### Safe operating area

$$I_D = f(V_{DS})$$

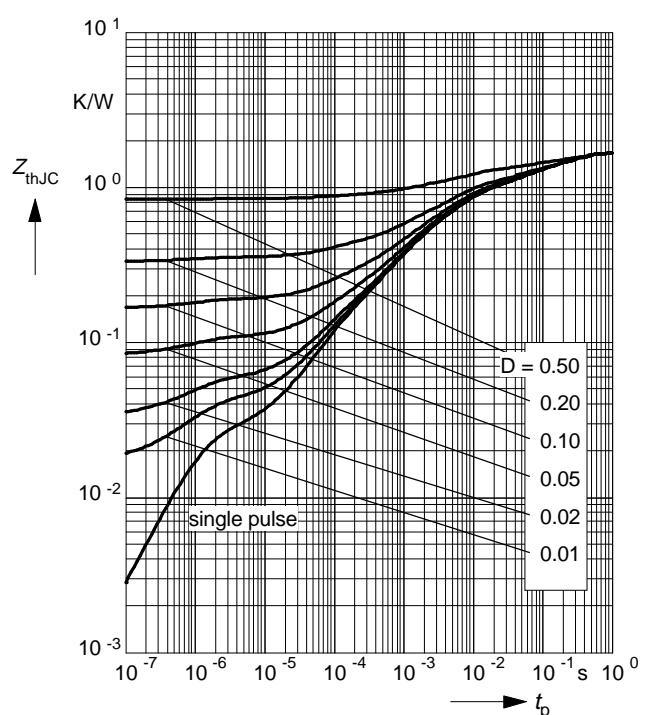
parameter:  $D = 0.01$ ,  $T_C = 25^\circ\text{C}$



### Transient thermal impedance

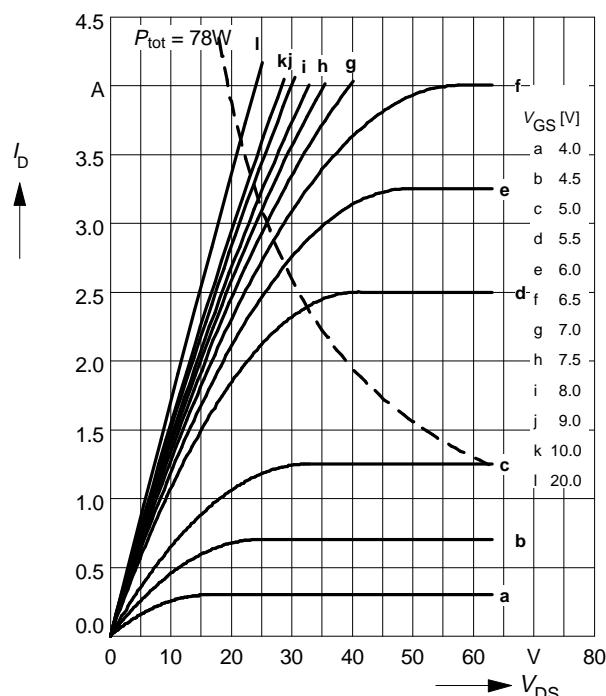
$$Z_{\text{thJC}} = f(t_p)$$

parameter:  $D = t_p / T$



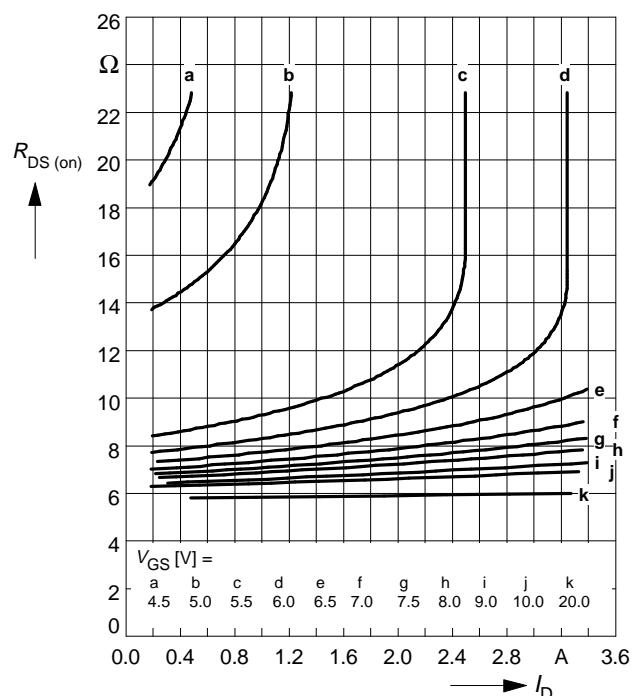
### Typ. output characteristics $I_D = f(V_{DS})$

parameter:  $t_p = 80 \mu s$



### Typ. drain-source on-resistance $R_{DS(on)} = f(I_D)$

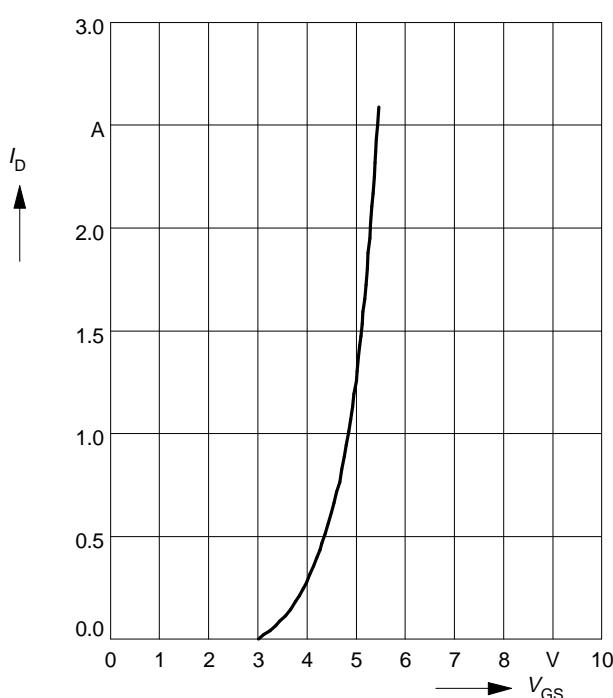
parameter:  $V_{GS}$



### Typ. transfer characteristics $I_D = f(V_{GS})$

parameter:  $t_p = 80 \mu s$

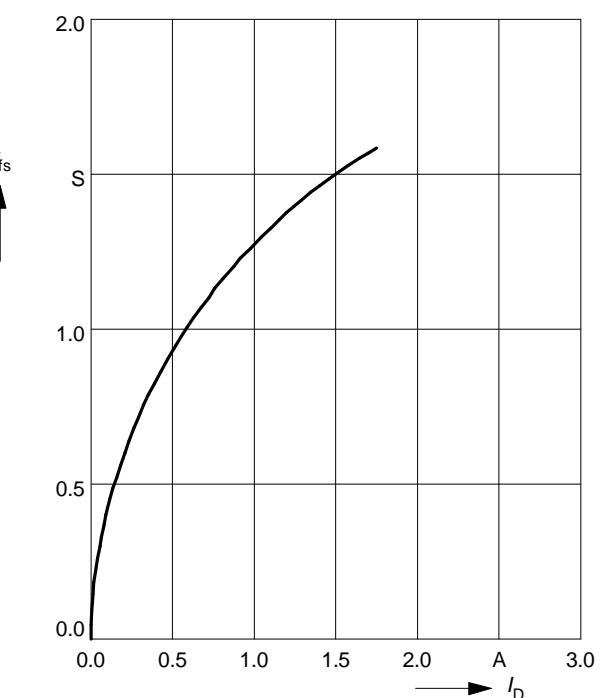
$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



### Typ. forward transconductance $g_{fs} = f(I_D)$

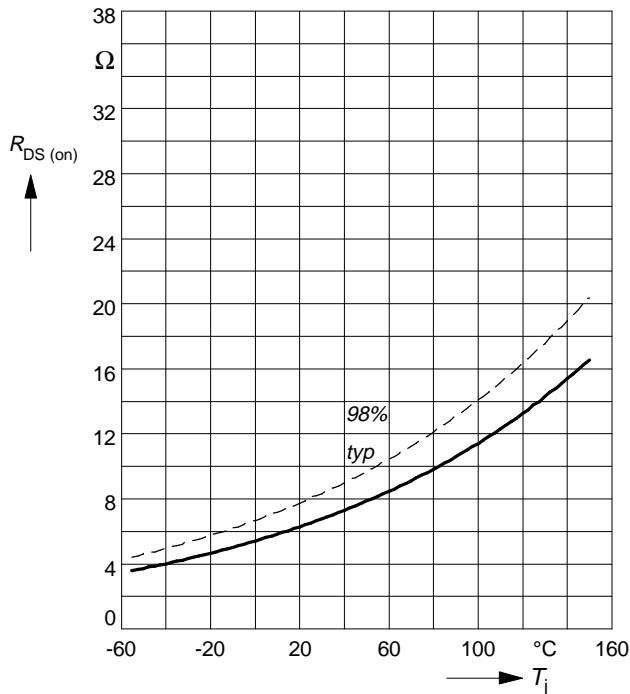
parameter:  $t_p = 80 \mu s$ ,

$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



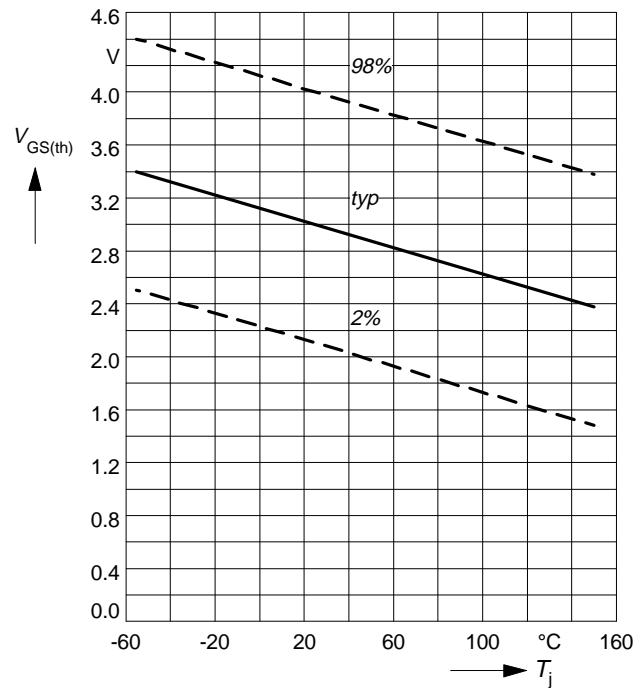
### Drain-source on-resistance

$R_{DS(on)} = f(T_j)$   
parameter:  $I_D = 1.5 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



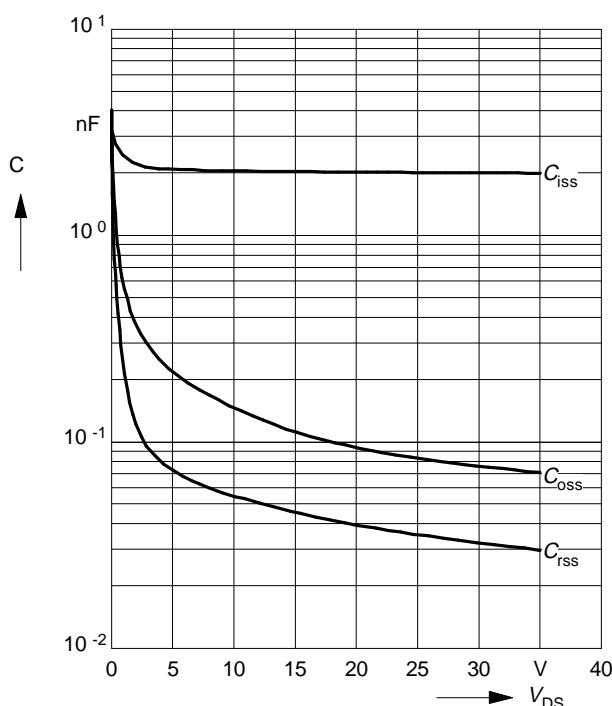
### Gate threshold voltage

$V_{GS(th)} = f(T_j)$   
parameter:  $V_{GS} = V_{DS}$ ,  $I_D = 1 \text{ mA}$



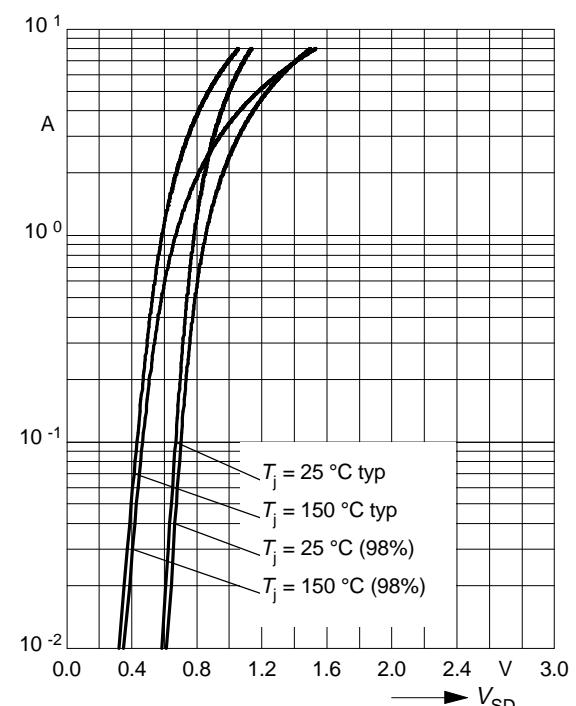
### Typ. capacitances

$C = f(V_{DS})$   
parameter:  $V_{GS} = 0 \text{ V}$ ,  $f = 1 \text{ MHz}$



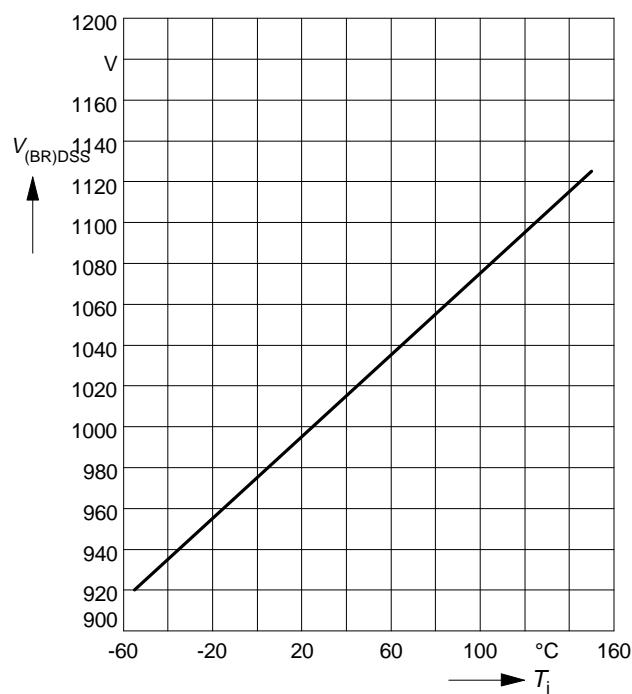
### Forward characteristics of reverse diode

$I_F = f(V_{SD})$   
parameter:  $T_j$ ,  $t_p = 80 \mu\text{s}$



### Drain-source breakdown voltage

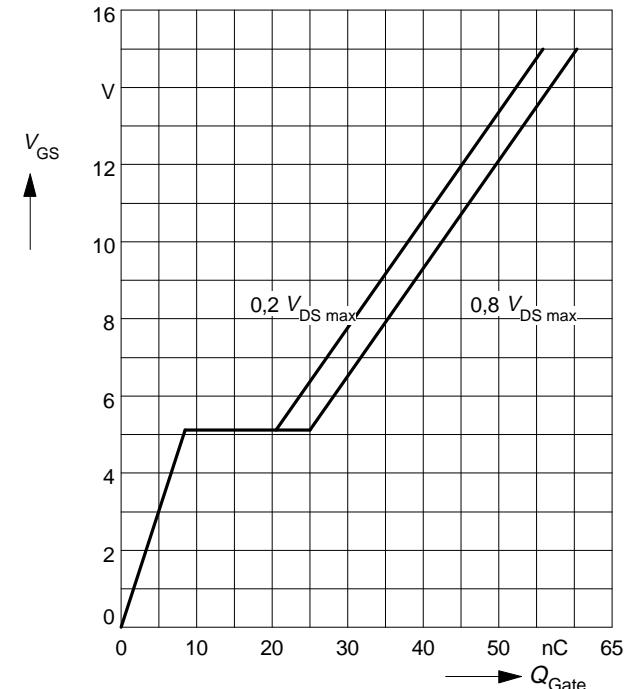
$$V_{(BR)DSS} = f(T_j)$$



### Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

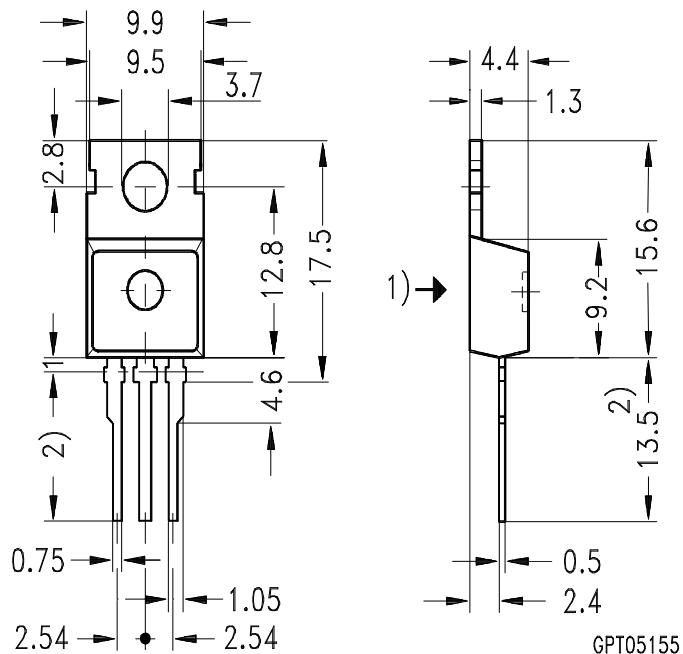
parameter:  $I_D$  puls = 4 A



**Package Outlines**

TO-220 AB

Dimension in mm



1) punch direction, burr max. 0.04

2) dip tinning

3) max. 14.5 by dip tinning press burr max. 0.05